## Application/Control N.S. Applicant(s)/Patent Under Reexamination PLAMPER ET AL. Examiner Armando Rodriguez Applicant(s)/Patent Under Reexamination PLAMPER ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4710631	12-1987	Aotsuka et al	250-354.1
	В	US-4604753	08-1986	Sawai	372-36
	С	US-5392303	02-1995	Shiozawa et al	372-32
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	j	US-			
	к	US-			
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	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	Q					
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## **NON-PATENT DOCUMENTS**

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